IAP20 RGC'd PCT/PTO 16 FEB 2006.

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Yukio KAWAGUCHI et al.

Application No.: New U.S. National Stage of

PCT/JP2004/010733

Filed: February 16, 2006 Docket No.: 127019

For: FLAT PANEL DISPLAY SPACER, METHOD OF MANUFACTURING FLAT PANEL

DISPLAY SPACER, AND FLAT PANEL DISPLAY

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of one or more non-English language reference is discussed in the present specification. See References 3-7.
- 3. One or more reference cited herein was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. See References 2, 7-9, and 13.
- 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 5. An English language Abstract of one or more non-English language reference is attached hereto. See References 5 and 8-10.

New U.S. National Stage of PCT/JP2004/010733

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6. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 3-9.

7. Reference 3 corresponds to Reference 10.

8. Reference 4 corresponds to Reference 11.

9. Reference 6 corresponds to Reference 12.

10. Reference 2 corresponds to Reference 7 and Reference 13.

Respectfully submitted,

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Date: February 16, 2006

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Please grant any extension necessary for entry; Charge any fee due to our Deposit Account No. 15-0461

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Sheet 1 of 1

Form PTO-1449 (REV. 1/06) INFORMA		US Dept. of Commerce PATENT & TRADEMARK OFFICE ATION DISCLOSURE STATEMENT		ATTY DOCKET NO. 127019 APPLICATION NO. New U.S. (National) Siege De PCT/JP2004/010733					
(Use several sheets if necessary)					APPLICANTS Yukio KAWAGUCHI et al.				
				FILING DATE February 16, 2006			GROUP		
U.S. PATENT DOCUMENTS									
Examiner Initials	Cite No.	Document Number	Date		Name				
	1	US 5,541,473	7/30/1996		DUBOC, JR. et al.				
	2	US 6,064,157	5/16/2000		SPINDT et al.				
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FOREIGN PATENT DOCUMENTS									
Examiner Initials	Cite No.	Document Number	Da	ite	Country		With English Abstract	With English Translation	
	3	JP A 2002-508110	3/12/200	2	JAPAN			х	
	4	JP A 2001-508926	7/3/2001		JAPAN			х	
	5	JP A 2001-068042	3/16/200	1	JAPAN		х	· x	
	6	JP A 11-500856	1/19/199	9	JAPAN			х	
	7	JP A 2002-515133	5/21/200	2	JAPAN			х	
	8	JP A 2004-146352	5/20/2004	4	JAPAN		х	х	
	9	JP A 2004-018296	1/22/2004	4	JAPAN		х	х	
	10	WO 99/01891	1/14/1999	9	WIPO		х		
	11	WO 99/00818	1/7/1999		WIPO				
	12	WO 96/30926	10/3/1996	6	WIPO				
	13	WO 98/03986	1/29/1998	В	WIPO				
			OTHER D	OCUME	NTS				
Examiner Initials	Cite (Including Author, Title, Date, Pertinent Pages, etc.) No.								
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EXAMINER	DATE CONSIDERED								
Examiner:	Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include conv of this form with next communication to applicant								

Date: February 16, 2006